

<b>Notice of References Cited</b>	Application/Control No. 10/562,168		Applicant(s)/Patent Under Reexamination TAKENAKA ET AL.	
	Examiner MCDIEUNEL MARC		Art Unit 3664	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,386,366	06-2008	Dariush, Behzad	700/245
*	B	US-7,191,036	03-2007	Takenaka et al.	700/245
*	C	US-5,459,659	10-1995	Takenaka, Toru	700/260
*	D	US-5,355,064	10-1994	Yoshino et al.	318/568.12
*	E	US-5,459,659	10-1995	Takenaka, Toru	700/260
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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